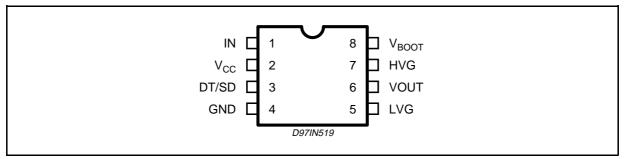
ABSOLUTE	MAXIMUM RATING	S
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Symbol	Parameter	Value	Unit
Vout	Output Voltage	-3 to Vboot -18	V
Vcc	Supply Voltage (*)	- 0.3 to 14.6	V
ls	Supply Current (*)	25	mA
Vboot	Floating Supply Voltage	-1 to 618	V
Vhvg	Upper Gate Output Voltage	-1 to Vboot	V
Vlvg	Lower Gate Output Voltage	-0.3 to Vcc +0.3	V
Vi	Logic Input Voltage	-0.3 to Vcc +0.3	V
Vsd	Shut Down/Dead Time Voltage	-0.3 to Vcc +0.3	V
dVout/dt	Allowed Output Slew Rate	50	V/ns
Ptot	Total Power Dissipation (Tj = 85 °C)	750	mW
Tj	Junction Temperature	150	°C
Ts	Storage Temperature	-50 to 150	°C

(\*) The device has an internal Clamping Zener between GND and the Vcc pin, It must not be supplied by a Low Impedence Voltage Source. **Note:** ESD immunity for pins 6, 7 and 8 is guaranteed up to 900 V (Human Body Model)

### **PIN CONNECTION**



# THERMAL DATA

Symbol	Symbol Parameter		Minidip	Unit
R <sub>th j-amb</sub>	ij-amb Thermal Resistance Junction to Ambient		100	°C/W

## **PIN DESCRIPTION**

N.	Name	Туре	Function
1	IN	Ι	Logic Input: it is in phase with HVG and in opposition of phase with LGV. It is compatible to $V_{CC}$ voltage. [Vil Max = 1.5V, Vih Min = 3.6V]
2	Vcc	I	Supply input voltage: there is an internal clamp [Typ. 15.6V]
3	DT/SD	I	High impedance pin with two functionalities. When pulled lower than Vdt [Typ. 0.5V] the device is shut down. A voltage higher than Vdt sets the dead time between high side gate driver and low side gate driver. The dead time value can be set forcing a certain voltage level on the pin or connecting a resistor between pin 3 and ground. Care must be taken to avoid below threshold spikes on pin 3 that can cause undesired shut down of the IC. For this reason the connection of the components between pin 3 and ground has to be as short as possible. This pin can not be left floating for the same reason. The pin has not be pulled through a low impedance to $V_{CC}$ , because of the drop on the current source that feeds Rdt. The operative range is: Vdt270K · Idt, that allows a dt range of 0.4 - 3.1 $\mu$ s.
4	GND		Ground

57

#### **PIN DESCRIPTION** (continued)

N.	Name	Туре	Function
5	LVG	0	Low Side Driver Output: the output stage can deliver 400mA source and 650mA sink [Typ. Values]. The circuit guarantees 0.3V max on the pin (@ $I_{sink} = 10mA$ ) with V <sub>CC</sub> > 3V and lower than the turn on threshold. This allows to omit the bleeder resistor connected between the gate and the source of the external mosfet normally used to hold the pin low; the gate driver ensures low impedance also in SD conditions.
6	Vout	0	Upper Driver Floating Reference: layout care has to be taken to avoid below ground spikes on this pin.
7	HVG	0	High Side Driver Output: the output stage can deliver 400mA source and 650mA sink [Typ. Values]. The circuit gurantees 0.3V max between this pin and Vout (@ $I_{sink} = 10mA$ ) with $V_{CC} > 3V$ and lower than the turn on threshold. This allows to omit the bleeder resistor connected between the gate and the source of the external mosfet normally used to hold the pin low; the gate driver ensures low impedance also in SD conditions.
8	Vboot		Bootstrap Supply Voltage: it is the upper driver floating supply. The bootstrap capacitor connected between this pin and pin 6 can be fed by an internal structure named "bootstrap driver" (a patented structure). This structure can replace the external bootstrap diode.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Pin	Parameter	Test Condition	Min.	Тур.	Max.	Unit
Vout	6	Output Voltage		Note1		580	V
Vboot - Vout	8	Floating Supply Voltage		Note1		17	V
fsw		Switching Frequency	HVG,LVG load CL = 1nF			400	kHz
Vcc	2	Supply Voltage				Vclamp	V
Tj		Junction Temperature		-45		125	°C

Note 1: If the condition Vboot - Vout < 18V is guaranteed, Vout can range from -3 to 580V.

#### ELECTRICAL CHARACTERISTICS AC Operation (V<sub>CC</sub> = 14.4V; Tj = 25°C)

Symbol	Pin	Parameter	Test Condition	Min.	Тур.	Max.	Unit
ton	1 vs 5,7	High/Low Side Driver Turn-On Propagation Delay	Vout = 0V $R_{dt} = 47k\Omega$		200+dt		ns
tonsd	3 vs 5,7	Shut Down Input Propagation Delay			220	280	ns
toff	1 vs 5,7	High/Low Side Driver Turn-Off Propagation Delay	Vout = 0V $R_{dt} = 47k\Omega$		250	300	ns
			Vout = $0V$ R <sub>dt</sub> = $146k\Omega$		200	250	ns
			Vout = $0V$ R <sub>dt</sub> = $270k\Omega$		170	200	ns
tr	7,5	Rise Time	CL = 1000pF		70		ns
tf	7,5	Fall Time	CL = 1000pF		30		ns

# DC Operation (V<sub>CC</sub> = 14.4V; Tj = 25°C)

Supply Voltage Section										
Vclamp	2	Supply Voltage Clamping	ls = 5mA	14.6	15.6	16.6	V			
Vccth1	2	Vcc UV Turn On Threshold		11.5	12	12.5	V			
Vccth2	2	Vcc UV Turn Off Threshold		9.5	10	10.5	V			

<b>L7/</b>		3/10

# DC Operation (continued)

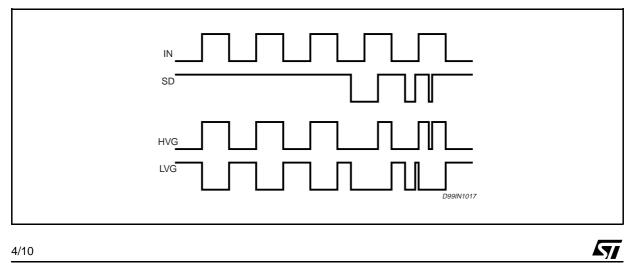
Symbol	Pin	Parameter	Test Condition	Min.	Тур.	Max.	Unit
Vcchys	2	Vcc UV Hysteresis			2		V
lqccu	2	Undervoltage Quiescent Supply Current	$Vcc \le 11V$		150		μΑ
lqcc	2	Quiescent Current	Vin = 0		380	500	μΑ
Bootstra	apped s	supply Voltage Section					
Vboot	8	Bootstrap Supply Voltage				17	V
IQBS		Quiescent Current	Vout = Vboot; IN = HIGH			200	μA
ILK		High Voltage Leakage Current	VHVG = Vout = Vboot = 600V			10	μΑ
Rdson		Bootstrap Driver on Resistance (*)	$Vcc \ge 12.5V$ ; IN = LOW		125		Ω
High/Lo	w Side	Driver					
lso	5,7	Source Short Circuit Current	$VIN = Vih (tp < 10\mu s)$	300	400		mA
lsi		Sink Short Circuit Current	$VIN = Vil (tp < 10\mu s)$	500	650		mA
Logic In	puts						
Vil	2,3	Low Level Logic Threshold Voltage				1.5	V
Vih		High Level Logic Threshold Voltage		3.6			V
lih		High Level Logic Input Current	VIN = 15V		50	70	μΑ
lil		Low Level Logic Input Current	VIN = 0V			1	μΑ
Iref	3	Dead Time Setting Current			28		μΑ
dt	3 vs 5,7	Dead Time Setting Range (**)	Rdt = 47k Rdt = 146 Rdt = 270k	0.4	0.5 1.5 2.7	3.1	μs μs μs
Vdt	3	Shutdown Threshold			0.5		V

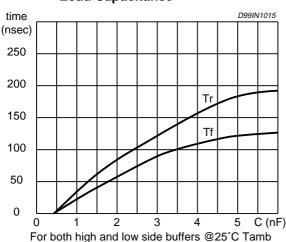
(\*)  $R_{DSON}$  is tested in the following way:  $R_{DSON} = \frac{(V_{CC} - V_{CBOOT1}) - (V_{CC} - V_{CBOOT2})}{I_1(V_{CC}, V_{CBOOT1}) - I_2(V_{CC}, V_{CBOOT2})}$ 

where  $I_1$  is pin 8 current when  $V_{CBOOT} = V_{CBOOT1}$ ,  $I_2$  when  $V_{CBOOT} = V_{CBOOT2}$ 

(\*\*) Pin 3 is a high impedence pin. Therefore dt can be set also forcing a certain voltage V<sub>3</sub> on this pin. The dead time is the same obtained with a Rdt if it is: Rdt  $\cdot$  Iref = V<sub>3</sub>.

# Figure 1. Input/Output Timing Diagram





#### Figure 2. Typical Rise and Fall Times vs. Load Capacitance

#### **BOOTSTRAP DRIVER**

A bootstrap circuitry is needed to supply the high voltage section. This function is normally accomplished by a high voltage fast recovery diode (fig. 4a). In the L6384 a patented integrated structure replaces the external diode. It is realized by a high voltage DMOS, driven synchronously with the low side driver (LVG), with in series a diode, as shown in fig. 4b

An internal charge pump (fig. 4b) provides the DMOS driving voltage .

The diode connected in series to the DMOS has been added to avoid undesirable turn on of it.

#### **CBOOT** selection and charging:

To choose the proper  $C_{BOOT}$  value the external MOS can be seen as an equivalent capacitor. This capacitor  $C_{EXT}$  is related to the MOS total gate charge :

$$C_{EXT} = \frac{Q_{gate}}{V_{gate}}$$

The ratio between the capacitors  $C_{\text{EXT}}$  and  $C_{\text{BOOT}}$  is proportional to the cyclical voltage loss .

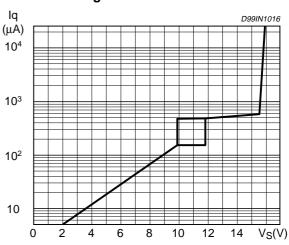
It has to be:

e.g.: if  $Q_{gate}$  is 30nC and  $V_{gate}$  is 10V,  $C_{EXT}$  is 3nF. With  $C_{BOOT} = 100$ nF the drop would be 300mV.

If HVG has to be supplied for a long time, the  $C_{\text{BOOT}}$  selection has to take into account also the leakage losses.

e.g.: HVG steady state consumption is lower than 200 $\mu A,$  so if HVG ToN is 5ms, CBOOT has to supply 1 $\mu C$  to CEXT. This charge on a 1 $\mu F$  ca-

57



# Figure 3. Quiescent Current vs. Supply Voltage

pacitor means a voltage drop of 1V.

The internal bootstrap driver gives great advantages: the external fast recovery diode can be avoided (it usually has great leakage current). This structure can work only if  $V_{OUT}$  is close to GND (or lower) and in the meanwhile the LVG is on. The charging time ( $T_{charge}$ ) of the  $C_{BOOT}$  is the time in which both conditions are fulfilled and it has to be long enough to charge the capacitor.

The bootstrap driver introduces a voltage drop due to the DMOS  $R_{DSON}$  (typical value: 125 Ohm). At low frequency this drop can be neglected. Anyway increasing the frequency it must be taken in to account.

The following equation is useful to compute the drop on the bootstrap DMOS:

$$V_{drop} = I_{charge} R_{dson} \rightarrow V_{drop} = \frac{Q_{gate}}{T_{charge}} R_{dson}$$

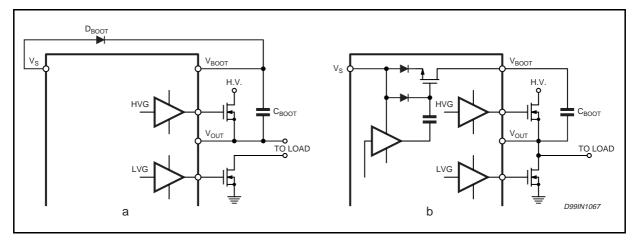
where  $Q_{gate}$  is the gate charge of the external power MOS,  $R_{dson}$  is the on resistance of the bootstrap DMOS, and  $T_{charge}$  is the charging time of the bootstrap capacitor.

For example: using a power MOS with a total gate charge of 30nC the drop on the bootstrap DMOS is about 1V, if the  $T_{charge}$  is 5µs. In fact:

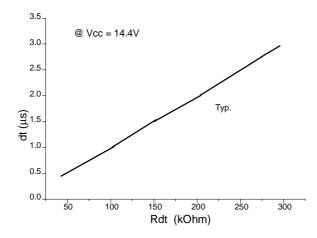
$$V_{drop} = \frac{30nC}{5\mu s} \cdot 125\Omega \sim 0.8V$$

 $V_{drop}$  has to be taken into account when the voltage drop on  $C_{BOOT}$  is calculated: if this drop is too high, or the circuit topology doesn't allow a sufficient charging time, an external diode can be used.

#### Figure 4. Bootstrap Driver



# Figure 5. Dead Time vs. Resistance.





3

2.5

2

1

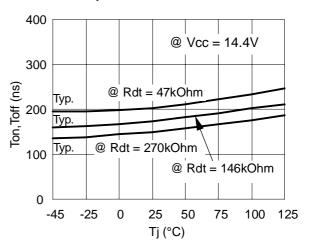
0.5

0

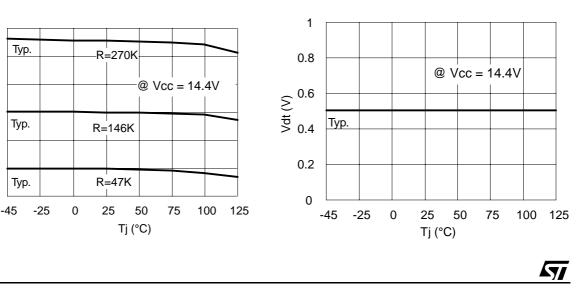
6/10

(sn) 1.5 tp









# Figure 9. Vcc UV Turn On vs. Temperature

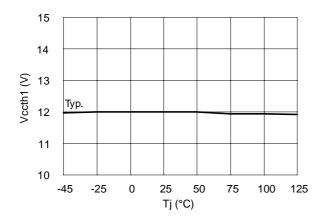
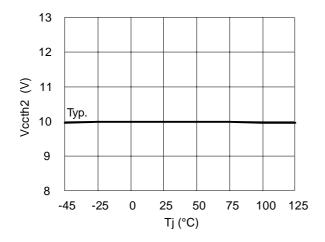
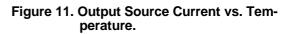


Figure 10. Vcc UV Turn Off vs. Temperature





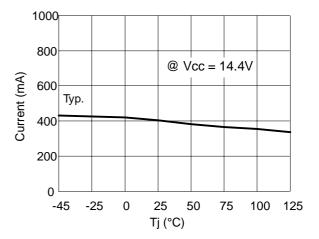
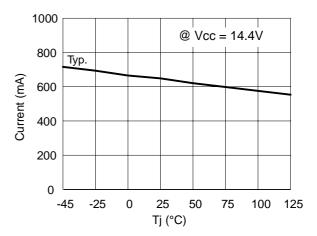
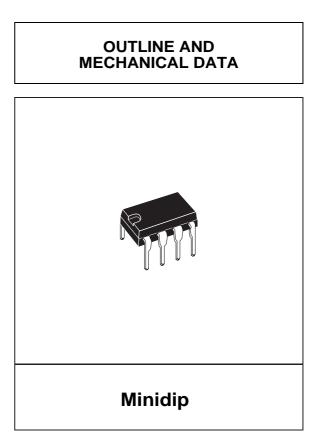


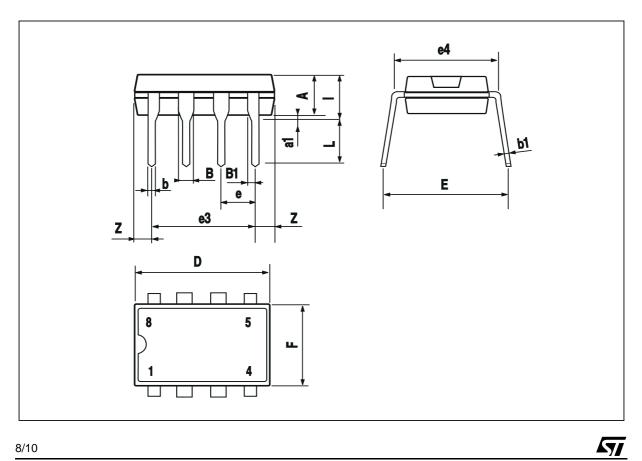
Figure 12. Output Sink Current vs. Temperature



57

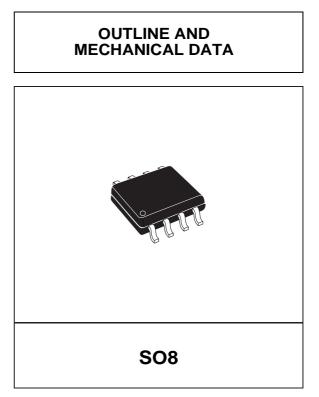
DIM.		mm		inch		
Dini.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А		3.32			0.131	
a1	0.51			0.020		
В	1.15		1.65	0.045		0.065
b	0.356		0.55	0.014		0.022
b1	0.204		0.304	0.008		0.012
D			10.92			0.430
E	7.95		9.75	0.313		0.384
е		2.54			0.100	
e3		7.62			0.300	
e4		7.62			0.300	
F			6.6			0.260
I			5.08			0.200
L	3.18		3.81	0.125		0.150
Z			1.52			0.060



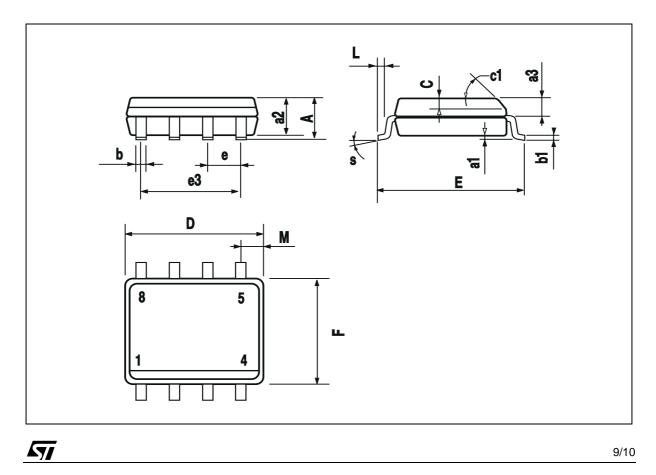


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DIM.		mm		inch			
Dilvi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А			1.75			0.069	
a1	0.1		0.25	0.004		0.010	
a2			1.65			0.065	
a3	0.65		0.85	0.026		0.033	
b	0.35		0.48	0.014		0.019	
b1	0.19		0.25	0.007		0.010	
С	0.25		0.5	0.010		0.020	
c1			45° (	(typ.)			
D (1)	4.8		5.0	0.189		0.197	
Е	5.8		6.2	0.228		0.244	
е		1.27			0.050		
e3		3.81			0.150		
F (1)	3.8		4.0	0.15		0.157	
L	0.4		1.27	0.016		0.050	
М			0.6			0.024	
S			8° (n	nax.)			



(1) D and F do not include mold flash or protrusions. Mold flash or potrusions shall not exceed 0.15mm (.006inch).



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57

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10/10